Issue	Classification	
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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/690,120	DESTRO-ET-AL.	
Examiner	Art Unit	
Kriellion A. Sanders	1714	

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			OR	IGINAL		CROSS REFERENCE(S)											
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NONE (Assistant Examiner) (Date)							LION A. SANE ARY EXAMIN		Total Claims Allowed: 14								
Y. Middle II/05 (Jegal Instruments Examiner) (Date)						(Pri	mary Evamine	. /	O. Print C	O.G. Print Fig							
						(Primary Examiner) (Date)			NO	NONE							

X	Claims renumbered in the same order as presented by applicant						□СРА			☐ T.D.			R.1.47						
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